

Device Modeling Report

COMPONENTS: THYRISTOR
PART NUMBER: BT300S-800R
MANUFACTURER: PHILIPS SEMICONDUCTOR



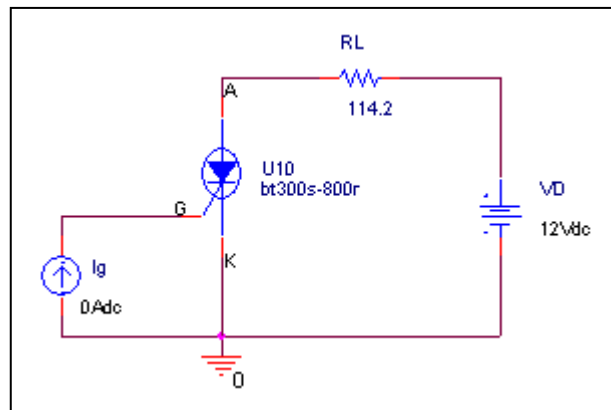
Bee Technologies Inc.

DIODE MODEL

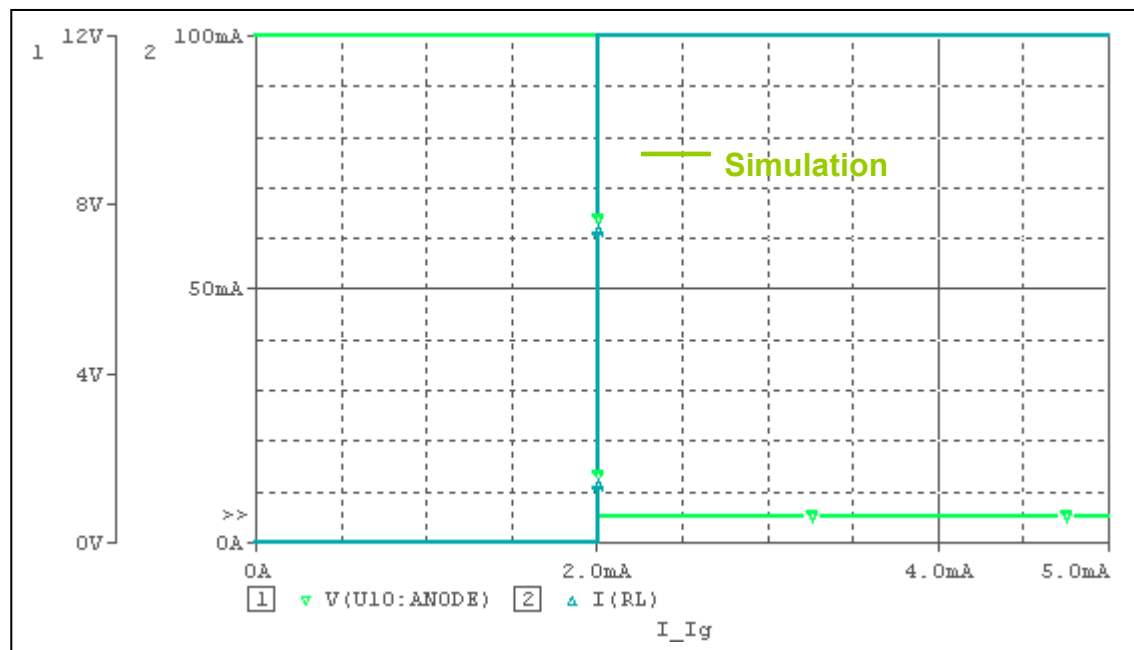
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

IG-VT Characteristic

Evaluation Circuit



Simulation result

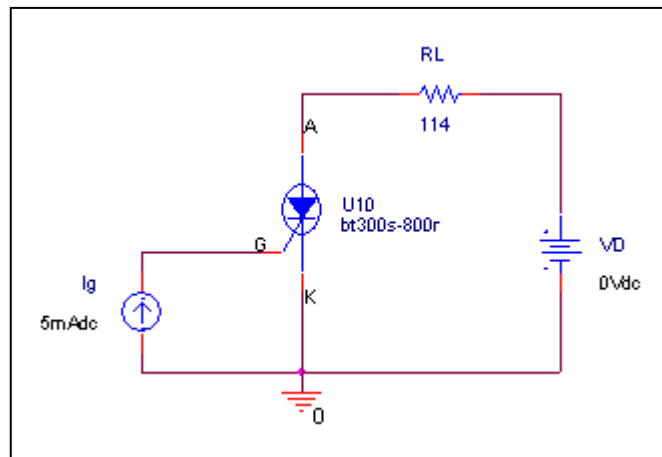


Comparison Table

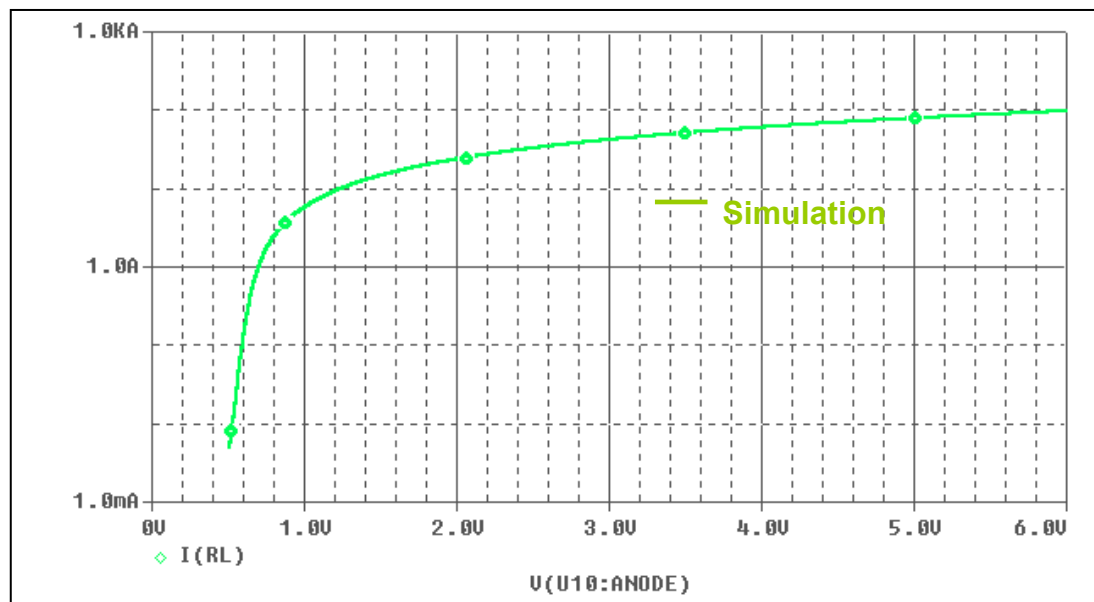
	Measurement	Simulation	% Error
I_{GT} (mA)	2	2.0044	0.22000
V_{GT} (V)	0.6	0.595065	-0.82250

ITM-VTM Characteristic

Evaluation Circuit



Simulation result

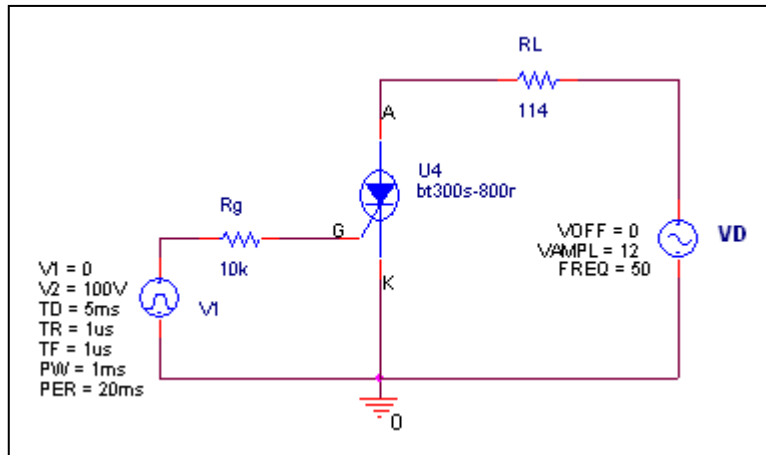


Comparison Table

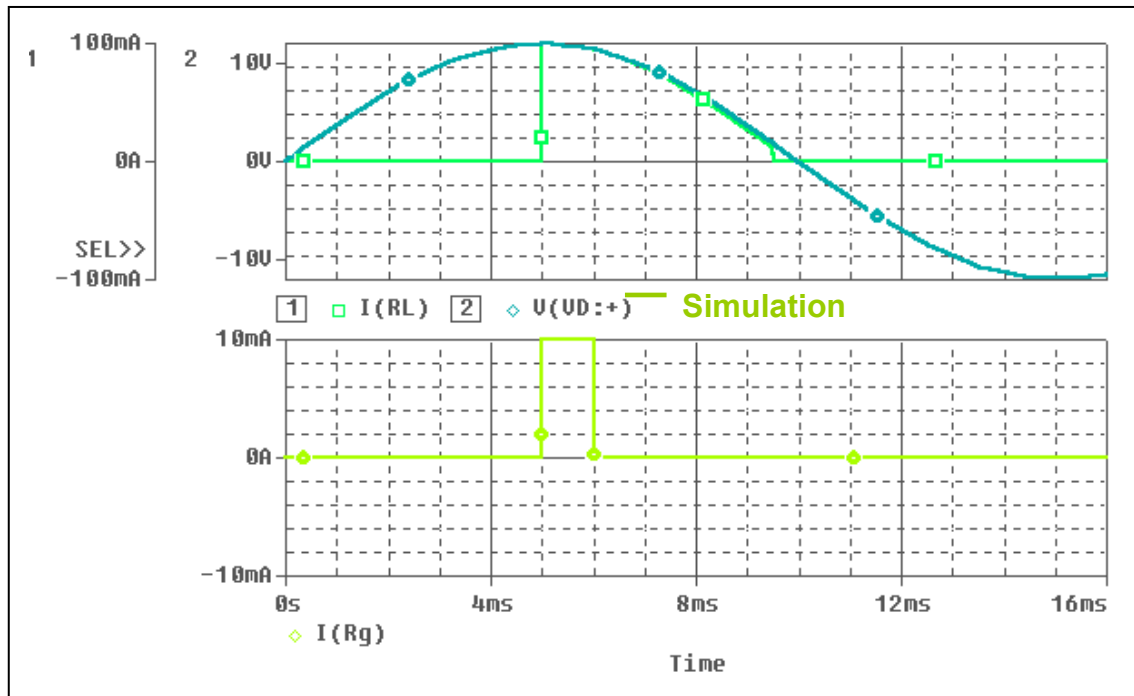
At ITM=12A	Measurement	Simulation	% Error
VTM(V)	1.35	1.3691	1.41481

Holding Characteristic (IH)

Evaluation Circuit



Simulation result

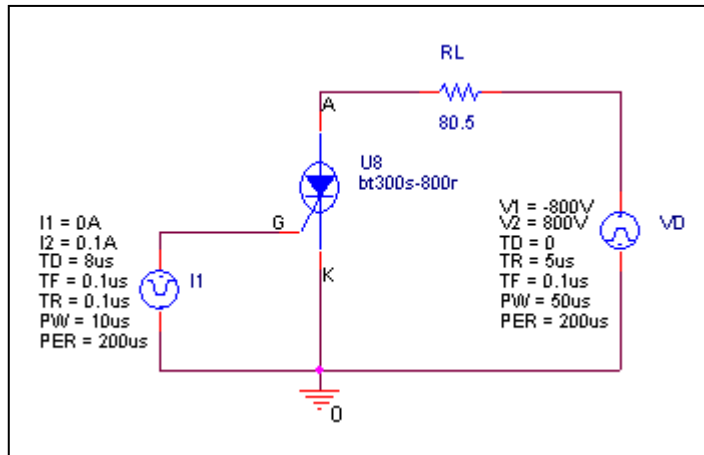


Comparison Table

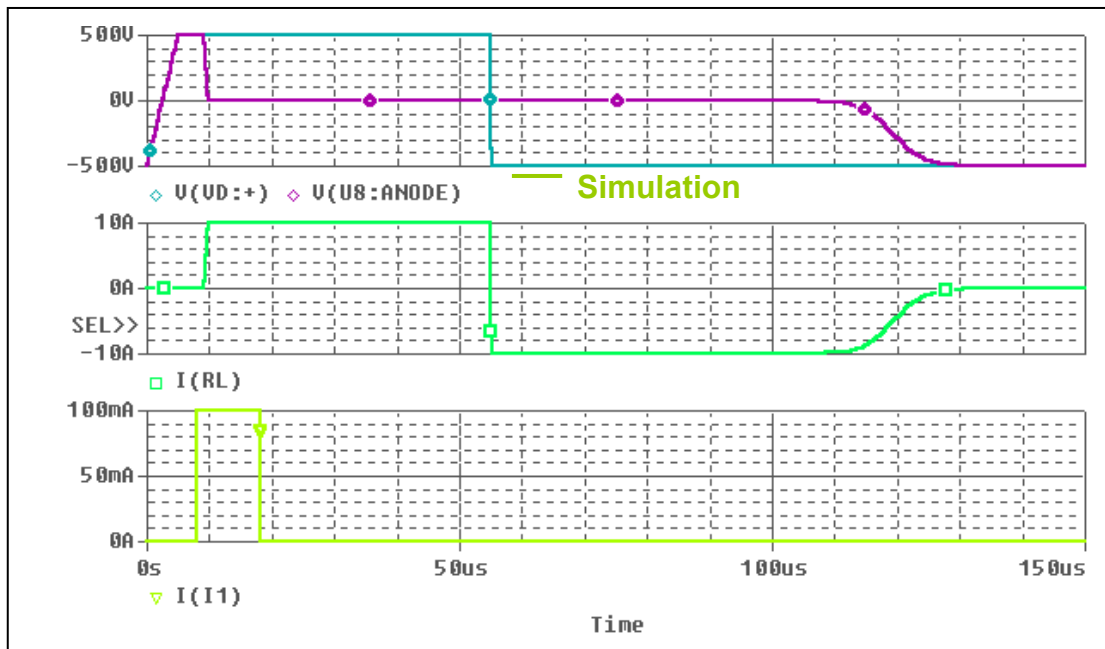
VD=12V	Measurement	Simulation	% Error
IH(mA)	10	10.045	0.45000

Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
Ton(us)	2	2.0063	0.31500
Toff(us)	70	69.224	-1.10857